

Power Management Switch ICs for PCs and Digital Consumer Products





# Power Switch IC for ExpressCard<sup>™</sup>

No.11029EAT26 BD4157MUV

#### Description

BD4157MUV is a power management switch IC for the next generation PC card (ExpressCard<sup>TM</sup>) developed by the PCMCIA. It conforms to the PCMCIA ExpressCard<sup>TM</sup> Standard, ExpressCard<sup>TM</sup> Compliance Checklist., and ExpressCard<sup>TM</sup> Implementation Guideline, and obtains Compliance ID "EC100395" from PCMCIA. The power switch offers a number of functions - card detector, and system status detector - which are ideally suited for laptop and desktop computers.

#### Features

- 1) Incorporates three low on-resistance FETs for ExpressCard<sup>TM</sup>.
- Incorporates an FET for output discharge.
- 3) Incorporates an enabler.
- 4) Incorporates under voltage lockout (UVLO) protection.
- 5) Employs an VQFN020V4040 package.
- Built-in thermal shutdown protector (TSD).
- Built-in thermal shutdown protector (TSD).
- 8) Incorporates an overcurrent protection (OCP).
- 9) Built-in enable signal for PLL

- Built-in Pull up resistance for detecting ExpressCard<sup>TM</sup>
   Conforms to the ExpressCard<sup>TM</sup> Standard.
   Conforms to the ExpressCard<sup>TM</sup> Compliance Checklist.
   Conforms to the ExpressCard<sup>TM</sup> Implementation Guideline.

Laptop and desktop computers, and other ExpressCard <sup>™</sup> equipped digital devices.

#### ●Product Lineup

Parameter	BD4157MUV
Package	VQFN020V4040

<sup>&</sup>quot;ExpressCard<sup>TM</sup>" is a registered trademark registered of the PCMCIA (Personal Computer Memory Card International Association).

● Absolute Maximum Ratings

Parameter	Symbol	Ratings	Unit
Input Voltage	V3AUX_IN, V3_IN, V15_IN	-0.3~4.5 * <sup>1</sup>	V
Logic Input Voltage 1	EN,CPPE#,CPUSB#,SYSR, PERST_IN#,RCLKEN	-0.3~V3AUX_IN+0.3 *1	V
Logic Output Voltage 1	RCLKEN	-0.3~V3AUX_IN+0.3 *1	V
Logic Output Voltage 2	PERST#	-0.3~V3AUX_IN+0.3	V
Output Voltage	V3AUX,V3, V15	-0.3~4.5 * <sup>1</sup>	V
Output Current 1	IOV3AUX	1.0	А
Output Current 2	IOV3	2.0	А
Output Current 3	IOV15	2.0	А
Power Dissipation 1	Pd1	0.34 *2	mW
Power Dissipation 2	Pd2	0.70 * <sup>3</sup>	mW
Operating Temperature Range	Topr	-40~+100	°C
Storage Temperature Range	Tstg	-55~+150	°C
Maximum Junction Temperature	Tjmax	+150	°C

<sup>\*1</sup> Not to exceed Pd.

#### ● Operating Conditions (Ta=25°C)

Parameter	Symbol	Ratir	Ratings		
Farameter	Symbol	MIN	MAX	Unit	
Input Voltage 1	V3AUX_IN	3.0	3.6	V	
Input Voltage 2	V3_IN	3.0	3.6	V	
Input Voltage 3	V15_IN	1.35	1.65	V	
Logic Input Voltage 1	EN	-0.3	3.6	V	
Logic Input Voltage 2	CPPE#,CPUSB#,SYSR, PERST_IN#,RCLKEN	0	V3AUX_IN	V	
Logic Output Voltage 1	RCLKEN	0	V3AUX_IN	V	
Logic Output Voltage 2	PERST#	0	V3AUX_IN	V	
Output Current 1	IOV3AUX	0	275	mA	
Output Current 2	IOV3	0	1.3	А	
Output Current 3	IOV15	0	650	mA	

<sup>★</sup> This product is not designed to offer protection against radioactive rays.

<sup>\*2</sup> Reduced by 2.7mW for each increase in Ta of 1°C over 25°C
\*3 Reduced by 5.6mW for each increase in Ta of 1°C over 25°C(When mounted on a board 74.2mm×74.2mm×1.6mm Glass-epoxy PCB).

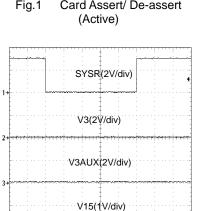
●ELECTRICAL CHARACTERISTICS (Unless otherwise noted, Ta=25°C, V3AUX\_IN =V3\_IN=3.3V, V15\_IN=1.5V VEN=OPEN.VSYSR=OPEN.CPPE#=0V.CPUSB#=OPEN.PERST\_IN#=OPEN)

Parameter	Symbol		Limits		Unit	Condition
		MIN	TYP	MAX		VEN=0V
Standby Current	IST	-	40	80	μA	(Include IEN, IRCLKEN)
Bias Current 1	Icc1	-	100	250	μΑ	VSYSR=0V, CPPE#=OPEN
Bias Current 2	Icc2	-	250	500	μΑ	
[Enable]	T	1		T	T	Т
High Level Enable Input Voltage	VENHI	2.0	-	3.6	V	
Low Level Enable Input Voltage	VENLOW	-0.2	-	0.8	V	
Enable Pin Input Current	IEN	10	-	30	μΑ	VEN=0V
[Logic]				l	l .	
High Level Logic Input Voltage	VLHI	2.0	-	-	V	
Low Level Logic Input Voltage	VLLOW	-	-	0.8	V	
	ICPPE#	-	0	1	μΑ	CPPE#=3.6V
	IOI-FE#	10	-	30	μA	CPPE#=0V
	ICPUSB#	_	0	1	μA	CPUSB#=3.6V
	10. 002	10	-	30	μA	CPUSB#=0V
Logic Pin Input Current	ISYSR	-	0	1	μA	SYSR=3.6V
		10	-	30	μA	SYSR=0V
	IPRT_IN#	-	0	1	μΑ	PERST_IN#=3.6V
		10	-	30	μA	PERST_IN#=0V RCLKEN=3.6V
	IRCLKEN	10	0	30	μA μA	RCLKEN=3.6V
RCLKEN Low Voltage	VRCLKEN	-	0.1	0.3	V	IRCLKEN=0.5mA
RCLKEN Leak Current	IRCLKEN	-	-	1	μA	VRCLKEN=3.6V
[Switch V3AUX]						
On Resistance	R <sub>V3AUX</sub>	-	140	220	mΩ	Tj=-10~100°C
Discharge On Resistance	R <sub>V3AUX</sub> Dis	-	30	150	Ω	
[Switch V3]						
On Resistance	R <sub>V3</sub>	-	50	90	mΩ	Tj=-10~100°C
Discharge On Resistance	R <sub>V3</sub> Dis	-	30	150	Ω	
[Switch V15]						
On Resistance	R <sub>V15</sub>	-	50	90	mΩ	Tj=-10~100°C
Discharge On Resistance	R <sub>V15</sub> Dis	-	30	150	Ω	
[Over Current Protection]						
V3 Over Current	OCP <sub>V3</sub>	1.3	-	-	А	
V3AUX Over Current	ОСР <sub>УЗАИХ</sub>	0.275	-	-	Α	
	OCP <sub>V15</sub>	0.65			Α	

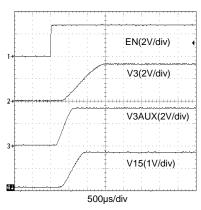
Damanatan	0		Limits		1.1:4			
Parameter	Symbol	MIN	TYP	MAX	Unit	Condition		
[Under Voltage Lockout]	[Under Voltage Lockout]							
V3_IN UVLO OFF Voltage	VUVLO <sub>V3_IN</sub>	2.60	2.80	3.00	V	sweep up		
V3_IN Hysteresis Voltage	△VUVLO <sub>V3_IN</sub>	50	100	150	mV	sweep down		
V3AUX_IN UVLO OFF Voltage	VUVLO <sub>V3AUX_IN</sub>	2.60	2.80	3.00	V	sweep up		
V3AUX_IN Hysteresis Voltage	△VUVLO <sub>V3AUX_IN</sub>	50	100	150	mV	sweep down		
V15_IN UVLO OFF Voltage	VUVLO <sub>V15_IN</sub>	1.10	1.20	1.30	V	sweep up		
V15_IN Hysteresis Voltage	∠VUVLO <sub>V15_IN</sub>	50	100	150	mV	sweep down		
[POWER GOOD]								
V3 POWER GOOD Voltage	PG <sub>V3</sub>	2.700	2.850	3.000	V			
V3AUX POWER GOOD Voltage	PG <sub>V3AUX</sub>	2.700	2.850	3.000	V			
V15 POWER GOOD Voltage	PG <sub>V15</sub>	1.200	1.275	1.350	V			
PERST# LOW Voltage	VPERST# <sub>Low</sub>	-	0.01	0.1	V	I <sub>PERST</sub> =0.5mA		
PERST# HIGH Voltage	VPERST# <sub>HIGH</sub>	3.0	-	-	V			
PERST# Delay Time	T <sub>PERST#</sub>	4	-	20	ms			
PERST# assertion time	Tast	-	-	500	ns			
[OUTPUT RISE TIME]								
V3_IN to V3	T <sub>V3</sub>	0.1	-	3	ms			
V3AUX_IN to V3AUX	T <sub>V3AUX</sub>	0.1	-	3	ms			
V15_IN to V15	T <sub>V15</sub>	0.1	-	3	ms			

## ●Reference data CPPE#(2V/div) V3(2V/div) V3AUX(2V/div) V15(1V/div) 5.0ms/div

Fig.1 Card Assert/ De-assert (Active)



5.0ms/div Fig.4 System Active ⇔Standby(No Card)



Wakeup Wave Form Fig.7 (Shut Down→Active)

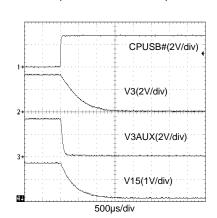


Fig.10 Power Down Wave Form (USB2.0 De-assert)

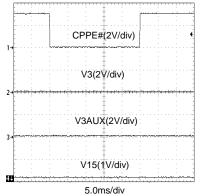
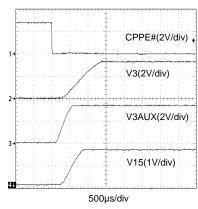
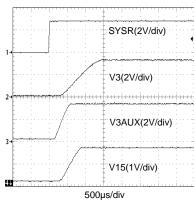


Fig.2 Card Assert/De-assert (Standby)



Wakeup Wave Form Fig.5 (Card Assert)



Wakeup Wave Form Fig.8 (Standby→Active)

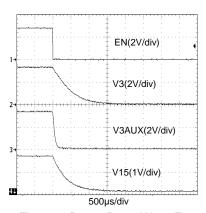


Fig.11 Power Down Wave Form (Active→Shut Down)

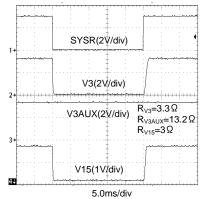


Fig.3 System Active ⇔Standbv( Card Present)

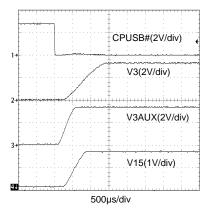
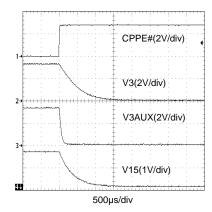
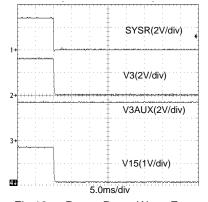


Fig.6 Wakeup Wave Form (USB2.0 Assert)



Power Down Wave Form Fig.9 (Card De-assert)



Power Down Wave Form Fig.12 (Active→Standby)

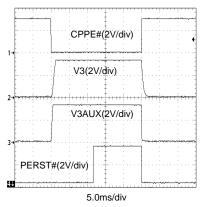
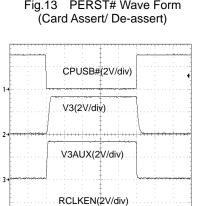


Fig.13 PERST# Wave Form



5.0ms/div **RCLKEN Wave Form** (USB2.0 Assert/ De-assert)

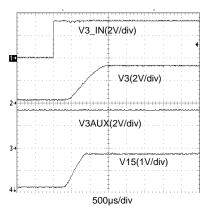


Fig.19 **Output Voltage** (V3\_IN:OFF→ON)

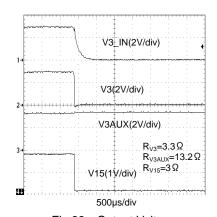


Fig.22 Output Voltage (V3\_IN:ON→OFF)

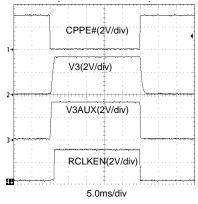


Fig.14 RCLKEN Wave Form (Card Assert/ De-assert)

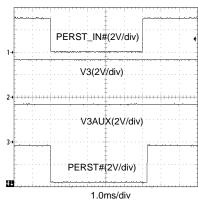


Fig.17 PERST# Wave Form (PERST\_IN# Input)

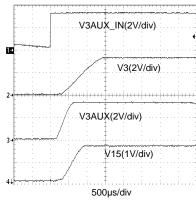


Fig.20 **Output Voltage** (V3AUX\_IN:OFF→ON)

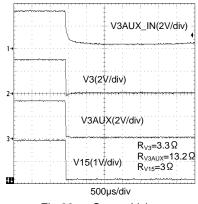


Fig.23 **Output Voltage** (V3AUX\_IN:ON→OFF)

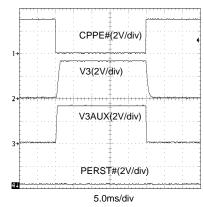


Fig.15 PERST# Wave Form (USB2.0 Assert/ De-assert)

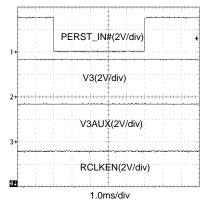


Fig.18 RCLKEN Wave Form (PERST\_IN# Input)

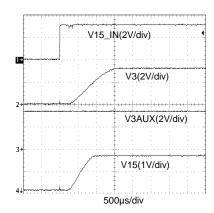
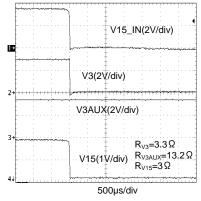
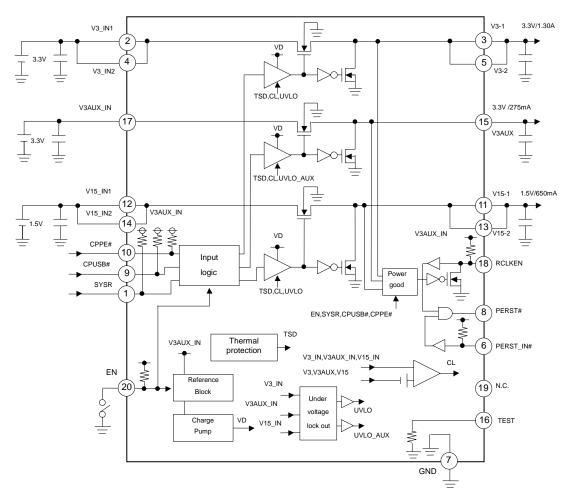


Fig.21 **Output Voltage** (V15\_IN:OFF→ON)

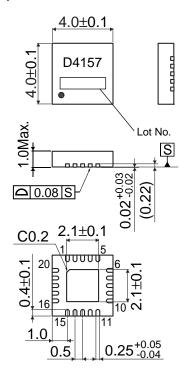


**Output Voltage** Fig.24 (V15\_IN:ON→OFF)

#### ●Block Diagram



#### Physical Dimensions



●Pin Function

Pin Functio	Pin Function				
PIN No	PIN NAME	PIN FUNCTION			
1	SYSR	Logic input pin			
2	V3_IN1	V3 input pin			
3	V3-1	V3 output pin			
4	V3_IN2	V3 input pin			
5	V3-2	V3 output pin			
6	PERST_IN#	PERST# control input pin (SysReset#)			
7	GND	GND pin			
8	PERST#	Logic output pin			
9	CPUSB#	Logic input pin			
10	CPPE#	Logic input pin			
11	V15-1	V15 output pin			
12	V15_IN1	V15 input pin			
13	V15-2	V15 output pin			
14	V15_IN2	V15 input pin			
15	V3AUX	V3AUX output pin			
16	TEST	Test pin. Must be open or GND.			
17	V3AUX_IN	V3AUX input pin 1			
18	RCLKEN	Reference clock enable signal/ Power good signal (No delay)			
19	N.C.	Must be open or GND.			
20	EN	Enable input pin			

VQFN020V4040 Package (Unit:mm)

#### Description of block operation

#### ΕN

With an input of 2.0 volts or higher, this terminal goes HIGH to activate the circuit, and goes LOW to deactivate the circuit (with the standby circuit current of 40 µA), It discharges each output and lowers output voltage when the input falls to 0.8 volts or less.

#### V3\_IN, V15\_IN, and V3AUX\_IN

These are the input terminals for each channel of a 3ch switch. V3\_IN and V15\_IN terminals have two pins each, which should be short-circuited on the pc board with a thick conductor. A large current runs through these three terminals: (V3\_IN: 1.3A; V3AUX\_IN: 0.275 A; and V15\_IN: 0.65 A). In order to lower the output impedance of the connected power supply, it is recommended that ceramic capacitors (with B-type characteristics or better) be provided between these terminals and the ground. Specifically, the capacitors should be on the order of 1 µF between V3\_IN and GND, and between V15\_IN and GND; and on the order of 0.1 µF between V3AUX\_IN and GND.

#### V3, V15, and V3AUX

These are the output terminals for each switch. The V3 and V15 terminals have two pins each, which should be short-circuited on the PC board and connected to an ExpressCard connector with a thick conductor, as short as possible. In order to stabilize the output, it is recommended that ceramic capacitors (with B-type characteristics or better) be provided between these terminals and the ground. Specifically, the capacitors should be on the order of 10  $\mu$ F between V3 and GND, and between V15 and GND; and on the order of 1  $\mu$ F between V3AUX and GND.

#### CPPE#

This pin is used to find whether or not a PCI-Express signal compatible card is present. Turns to "High" level with an input of 2.0 volts or higher, which means that no card is provided, while it turns to "Low" level when the input is lowered to 0.8 volts or less, which means that a card is provided. Controls the ON/OFF, switch selecting the proper mode based on the status of the system. Pull up resistance  $(100k\Omega \sim 200k\Omega)$  is built into, so the number of components is reduced.

#### CPUSB#

This pin is used to find whether or not a USB2.0 signal compatible card is present. Turns to "High" level with an input of 2.0 volts or higher, which means that no card is provided, while it turns to "Low" level when the input is lowered to 0.8 volts or less, which means that a card is provided. Controls the ON/OFF switch, selecting the proper mode based on the system status. Pull up resistance  $(100 \text{k}\Omega \sim 200 \text{k}\Omega)$  is built into, so the number of components is reduced.

#### SYSR

This pin is used to detect the system status. Turns to "High" level with an input of 2.0 volts or higher, which means that the system is activated, while it turns to "Low" level when the input is lowered to 0.8 volts or less, which means that the system is on standby.

#### PERST\_IN#

This pin is used to control the reset signal (PERST#) to a card from the system side. (Also referred to as "SysReset#" by PCMCIA.) Turns to "High" level with an input of 2.0 volts or higher, and sets PERST# to "High" AND with a "Power Good" output. Turns to "Low" level and sets PERST# to "Low" when the input falls to 0.8 volts or less.

#### PERST#

This pin is used to send a reset signal to a PCI-Express compatible card. Reset status is determined by the outputs, PERST\_IN#, CPPE# system status, and EN on/off status. Turns to "High" level and activates the PCI-Express compatible card only if each output is within the "Power Good" threshold, with the card inserted and PERST\_IN# turned to "High" level.

#### **RCLKEN**

This pin is used to send an enable signal to the reference clock. Activation status is determined by the outputs, CPPE# system status, and EN on/off status. Turns to "High" level and activates the reference clock PLL only if each output is within the "Power Good" threshold, with the card kept inserted.

#### TEST

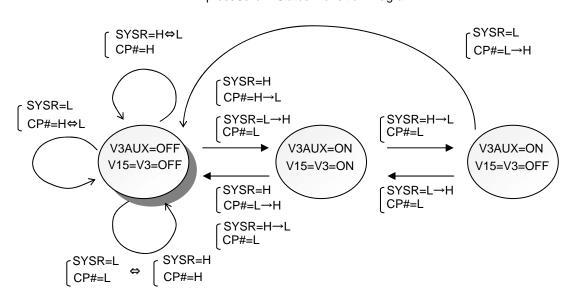
This pin is used to test, which should be short-circuited to the GND. When it is short-circuited to V3AUX\_IN, UVLO (V3\_IN, V15\_IN) turns OFF.

#### ●Timing Chart

Power ON/OFF Status of ExpressCard<sup>TM</sup>

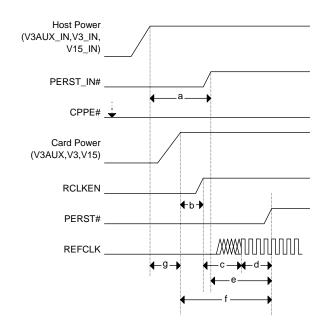
System	Status	ExpressCard <sup>TM</sup> Module	Power Swit	ch Status		
Primary	Auxiliary	Status	Primary (+3.3V and +1.5V)	Auxiliary (3.3V Aux)		
OFF	OFF	Don't care	OFF	OFF		
ON	ON	De-asserted	OFF	OFF		
ON	ON	ON	ON	Asserted	ON	ON
		De-asserted	OFF	OFF		
ON	ON	Asserted Before This	OFF	ON		
		Asserted After This	OFF	OFF		

## ExpressCard<sup>TM</sup> States Transition Diagram



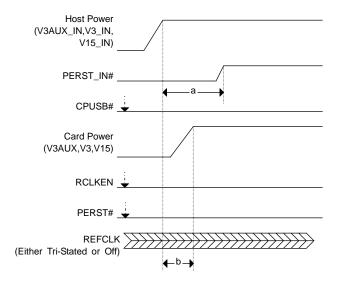
System Status		Card Status	
Stand-by Status	:SYSR=L	Card Asserted Status	:CP#=L
ON Status	:SYSR=H	Card De-asserted Status	:CP#=H
From ON to Stand-by Status	:SYSR=H→L	From De-asserted to Asserted Status	:CP#=H→L
From Stand-by to ON Status	:SYSR=L→H	From Asserted to De-asserted Status	:CP#=L→H

### ●ExpressCard<sup>TM</sup> Timing Diagrams



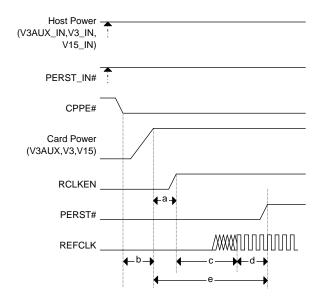
Timing Signals-Card Present Before Host Power is On

	1		
Tpd	Min	Max	Units
а	System D	ependent	
b	-	100	μs
С	System D		
d	System D		
е	100	-	μs
f	4	4 20	
g	-	10	ms



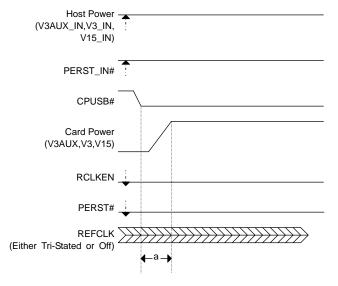
Timing Signals-USB Present Before Host Power is On

Tpd	Min	Max	Units	
а	System D	System Dependent		
b	-	- 10		



Timing Signals Host Power is On Prior to Card Insertion

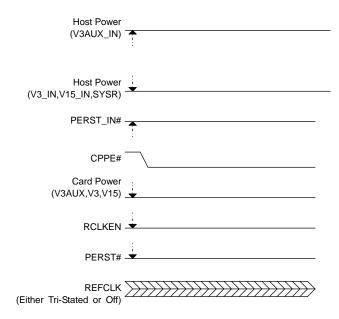
Tpd	Min	Max	Units	
а	-	100	μs	
b	-	10	ms	
С	System D	System Dependent		
d	System D	System Dependent		
е	4	10	ms	



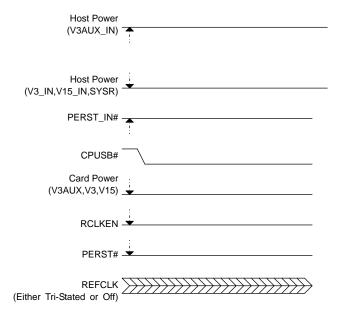
Timing Signals Host Power is On Prior to USB Insertion

Tpd	Min	Max	Units
а	-	10	ms

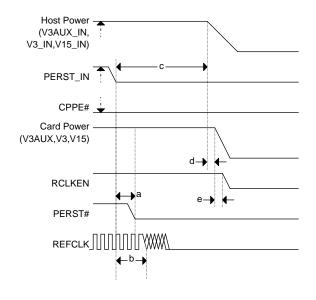
#### Application Information (continued)



Timing Signals-Host System In Standby Prior to Card Insertion

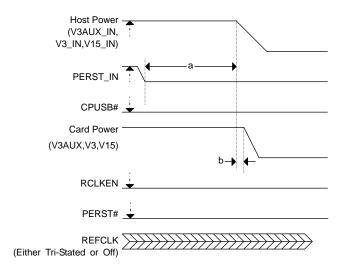


Timing Signals-Host System In Standby Prior to USB Insertion



Timing Signals Host Controlled Power Down

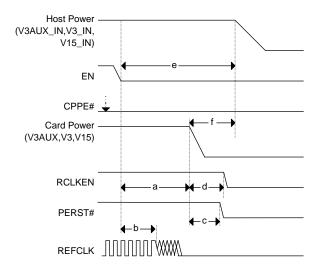
Tpd	Min	Min Max	
а	-	- 2	
b	System D		
С	System D		
d	Load De		
е	-	- 2	



Timing Signals Host Controlled Power Down

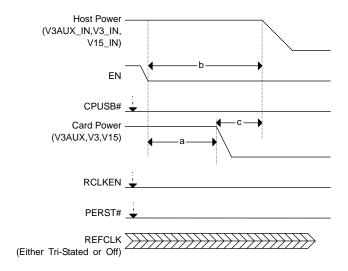
Tpd	Min	Max	Units
а	System D		
b	Load Dependent		

#### Application Information (continued)



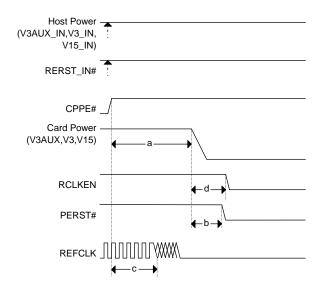
Timing Signals Controlled Power Down When EN Asserted

Tpd	Min	Min Max			
а	Load De	pendent			
b	System D	System Dependent			
С	-	- 500			
d	-	μs			
е	System D				
f	System D				



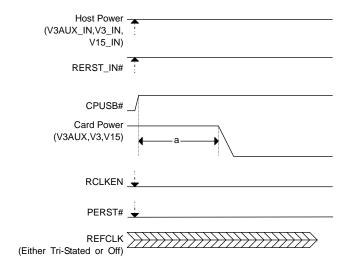
Timing Signals Controlled Power Down When EN Asserted

Tpd	Min	Max	Units		
а	Load De	Load Dependent			
b	System D				
С	System D				



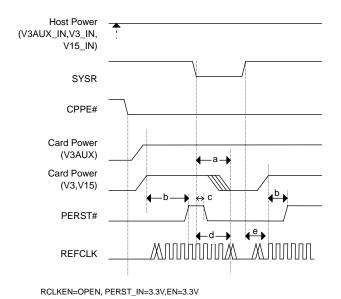
Timing Signals-Surprise Card Removal

Tpd	Min	Max	Units	
а	Load De	Load Dependent		
b	-	- 500		
С	System D	System Dependent		
d	-	2	μs	



Timing Signals-Surprise USB Removal

Tpd	Min	Max	Units
а	Load De	Load Dependent	



а	System D		
b	4	20	ms
С	-	- 2	
d	System D		
е	System D		

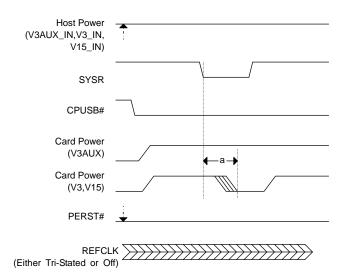
Max

Units

Min

Tpd

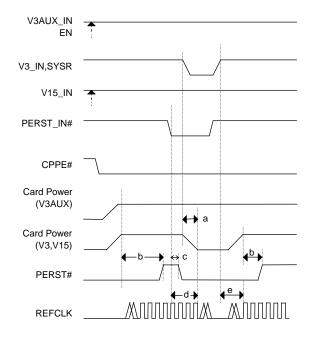
Timing Signals Power state transitions (Signal applies for SYSR)



Tpd	Min	Max	Units
а	System D	ependent	

RCLKEN=OPEN, PERST\_IN=3.3V,EN=3.3V

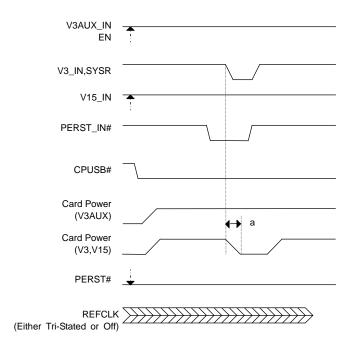
Timing Signals Power state transitions (Signal applies for SYSR)



Tpd	Min	Max	Units		
а	System D				
b	4	4 20			
С	-	μs			
d	System D				
е	System D				

RCLKEN=OPEN, PERST\_IN# is asserted in advance of power changes.

Timing Signals – Power state transitions (SYSR and EN are connected to V3\_IN/V3AUX\_IN.)



Tpd	Min	Max	Units
а	System D	ependent	

RCLKEN=OPEN, PERST\_IN# is asserted in advance of power changes.

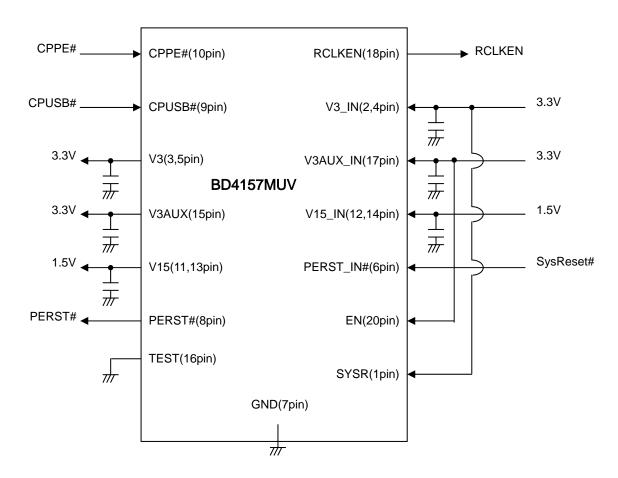
Timing Signals – Power state transitions (SYSR and EN are connected to V3\_IN/V3AUX\_IN.)

●Output Condition List(Output)

atput comunic	· · = · · · · · · · · · · · · · · · · ·								
State		Power Supply	,		Logic	input		Ou	tput
State	V3AUX_IN	V3_IN	V15_IN	EN	SYSR	CPPE#	CPUSB#	V3/V15	V3AUX
OFF	0	×	×	×	×	×	×	OFF	OFF
Shut down	1	×	×	0	×	×	×	OFF	OFF
ON						1	1	OFF	OFF
$\downarrow$	1	×	×	1	1→0	×	0	OFF	ON
Stand-by						0	×	OFF	ON
Stand-by	1	×	×	1	0	×	×	OFF	OFF
						1	1	OFF	OFF
ON	1	1	1	1	1	×	0	ON	ON
						0	×	ON	ON

State	Logic	cinput	Logic	Logic output		
State	PERST_IN#	RCLKEN(Input)	PERST#	RCLKEN		
OFF	×	×	0	0		
Shut down	×	×	0	0		
Stand-by	×	×	0	0		
ON(No Card)	×	×	0	0		
	0	Hiz	0	0		
ON(CPUSB#=0)	0	0	0	0		
ON(CPU3B#=0)	1	Hiz	0	0		
	1	0	0	0		
	0	Hiz	0	1		
ON(CPPE#=0)	0	0	0	0		
ON(OFPE#=0)	1	Hiz	1	1		
	1	0	0	0		

● Application Circuit (Circuit for ExpressCard TM Compliance Checklist)



#### ●Heat loss

Thermal design should allow the device to operate within the following conditions. Note that the temperatures listed are the allowed temperature limits. Thermal design should allow sufficient margin from these limits.

- 1. Ambient temperature Ta can be no higher than 100°C.
- 2. Chip junction temperature Tj can be no higher more than 150°C.

Chip junction temperature Tj can be determined as follows:

Chip junction temperature Tj is calculated from ambient temperature Ta: Tj=Ta+  $\theta$  j-a × W

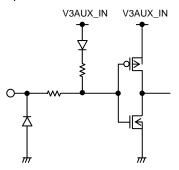
#### <Reference value>

 $\theta$  j-c:VQFN020V4040 367.6°C/W IC only 178.6°C/W 1-layer (copper foil density 10.29mm²) 56.6°C/W 4-layer (copper foil density 10.29mm²/ 2,3-layer copper foil density 5505mm²) 35.1°C/W 4-layer (copper foil density 5505mm²) Substrate size  $74.2 \times 74.2 \times 1.6$ mm³ (thermal vias in the board.)

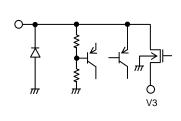
Most of heat loss in the BD4157MUV occurs at the output switch. The power lost is determined by multiplying the on-resistance by the square of output current of each switch.

### ● Equivalent Circuit

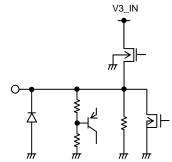
. 1pin<SYSR>



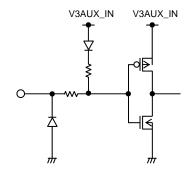
2,4pin<V3\_IN>



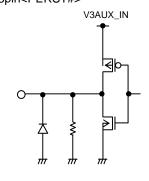
3,5pin<V3>



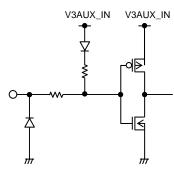
6pin<PERST\_IN#>



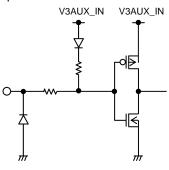
8pin<PERST#>



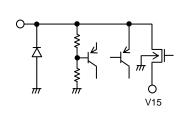
9pin<CPUSB#>



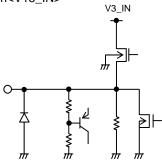
10pin<CPPE#>



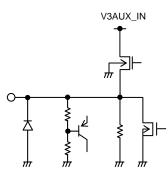
11,13pin<V15>



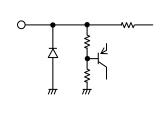
12,14pin<V15\_IN>



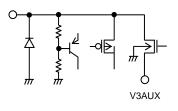
15pin<V3AUX>



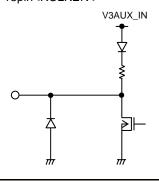
16pin<TEST>



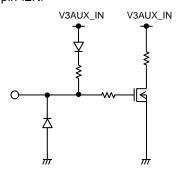
17pin<V3AUX\_IN>



18pin<RCLKEN >



20pin<EN>



#### Notes for use

#### 1. Absolute maximum ratings

Although quality is rigorously controlled, the device may be destroyed when applied voltage, operating temperature, etc. exceeds its absolute maximum rating. Because the source (short mode or open mode) cannot be identified once the IC is destroyed, it is important to take physical safety measures such as fusing when implementing any special mode that operates in excess of absolute rating limits.

#### Thermal design

Consider allowable loss (Pd) under actual operating conditions and provide sufficient margin in the thermal design.

#### 3. Terminal-to-terminal short-circuit and mis-mounting

When the mounting the IC to a printed circuit board, take utmost care to assure the position and orientation of the IC are correct. In the event that the IC is mounted erroneously, it may be destroyed. The IC may also be destroyed when a short-circuit is caused by foreign matter introduced into the clearance between outputs, or between an output and power-GND.

#### 4. Operation in strong electromagnetic fields

Using the IC in strong electromagnetic fields may cause malfunctions. Exercise caution in respect to electromagnetic fields.

#### 5. Built-in thermal shutdown protection circuit

This IC incorporates a thermal shutdown protection circuit (TSD circuit). The working temperature is 175°C (standard value) with a -15°C (standard value) hysteresis width. When the IC chip temperature rises the TSD circuit is activated, while the output terminal is brought to the OFF state. The built-in TSD circuit is intended exclusively to shut down the IC in a thermal runaway event, and is not intended to protect the IC or guarantee performance in these conditions. Therefore, do not operate the IC after with the expectation of continued use or subsequent operation once this circuit is activated.

#### 6. Capacitor across output and GND

When a large capacitor is connected across the output and GND, and the V3AUX\_IN is short-circuited with 0V or GND for any reason, current charged in the capacitor flows into the output and may destroy the IC. Therefore, use a capacitor smaller than 1000  $\mu$ F between the output and GND.

#### 7. Set substrate inspection

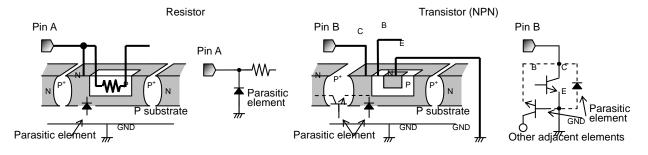
Connecting a low-impedance capacitor to a pin when running an inspection with a set substrate may produce stress on the IC. Therefore, be certain to discharge electricity at each process of the operation. To prevent electrostatic accumulation and discharge in the assembly process, thoroughly ground yourself and any equipment that could sustain ESD damage, and continue observing ESD-prevention procedures in all handling, transfer and storage operations. Before attempting to connect the set substrate to the test setup, make certain that the power supply is OFF. Likewise, be sure the power supply is OFF before removing the substrate from the test setup.

#### 8. IC terminal input

This integrated circuit is a monolithic IC, with P substrate and  $P^+$  isolation between elements.

The P layer and N layer of each element form a, PN junction. When the potential relation is GND>terminal A>terminal B, the PN junction works as a diode, and when terminal B>GND terminal A, the PN junction operates as a parasitic transistor.

Parasitic elements inevitably form, due to the nature of the IC construction. The operation of the parasitic element gives rise to mutual interference between circuits and results in malfunction, and eventually, breakdown. Consequently, take utmost care not to use the IC in a way that would cause the parasitic element to actively operate, such as applying voltage lower than GND (P substrate) to the input terminal.



#### 9. GND wiring pattern

If both a small signal GND and a high current GND are present, it is recommended that the patterns for the high current GND and the small signal GND be separated. Proper grounding to the reference point of the set should also be provided. In this way, the small signal GND voltage will by unaffected by the change in voltage stemming from the pattern wiring resistance and the high current. Also, pay special attention to avoid undesirable wiring pattern fluctuations in any externally connected GND component.

#### 10. Electrical characteristics

The electrical characteristics in the Specifications may vary, depending on ambient temperature, power supply voltage, circuit(s) externally applied, and/or other conditions. Therefore, please check all such factors, including transient characteristics, that could affect the electrical characteristics.

#### 11. Capacitors applied to input terminals

The capacitors applied to the input terminals (V3\_IN, V3AUX\_IN and V15\_IN) are used to lower the output impedance of the connected power supply. An increase in the output impedance of the power supply may result in destabilization of input voltages (V3\_IN, V3AUX\_IN and V15\_IN). It is recommended that a low-ESR capacitor be used, with a lower temperature coefficient (change in capacitance vs. change in temperature), Recommended capacitors are on the order of 0.1  $\mu$ F for V3AUX\_IN, and1  $\mu$ F for V3\_IN and V15\_IN. However, they must be thoroughly checked at the temperature and with the load range expected in actual use, because capacitor selection depends to a significant degree on the characteristics of the input power supply to be used and the conductor pattern of the PC board.

#### 12. Capacitors applied to output terminals

Capacitors for the output terminals (V3, V3\_AUX, and V15), should be connected between each of the output terminals and GND. A low-ESR, low temperature coefficient output capacitor is recommended-on the order of 1  $\mu$ F for V3 and V15 terminals, and 1 $\mu$ F less for V3\_AUX. However, they must be thoroughly checked at the temperature and with the load range expected in actual use, because capacitor selection depends to a significant degree on the temperature and the load conditions.

13. Not of a radiation-resistant design.

#### 14. Allowable loss (Pd)

With respect to the allowable loss, please refer to the thermal derating characteristics shown in the Exhibit, which serves as a rule of thumb. When the system design causes the IC to operate in excess of the allowable loss, chip temperature will rise, reducing the current capacity and decreasing other basic IC functionality. Therefore, design should always enable IC operation within the allowable loss only.

#### 15. Operating range

Basic circuit functions and operations are warranted within the specified operating range the working ambient temperature range. Although reference values for electrical characteristics are not warranted, no rapid or extraordinary changes in these characteristics are expected, provided operation is within the normal operating and temperature range.

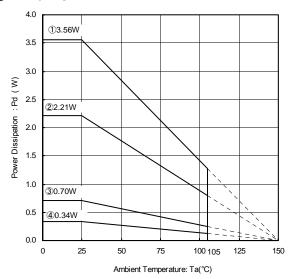
- 16. The applied circuit example diagrams presented here are recommended configurations. However, actual design depends on IC characteristics, which should be confirmed before operation. Also, note that modifying external circuits may impact static, noise and other IC characteristics, including transient characteristics. Be sure to allow sufficient margin in the design to accommodate these factors.
- 17. Wiring to the input terminals (V3 IN, V3AUX IN, and V15 IN) and output terminals (V3, V3AUX and V15) of the built-in FET should be carried out with special care. Using unnecessarily long and/or thin conductors may decrease output voltage and degrade other characteristics.

#### 18. Heatsink

The heatsink is connected to the SUB, which should be short-circuited to the GND. Proper heatsink soldering to the PC board should enable lower thermal resistance.

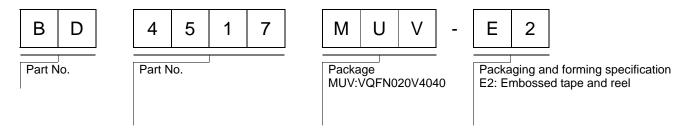
#### ●Power Dissipation

⊚BD4157MUV

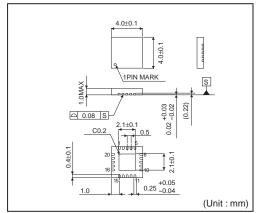


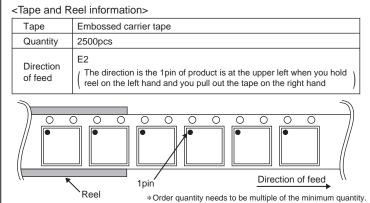
- ①4-layer (copper foil density 5505mm²)  $\theta$  j-a=35.1°C/W
- (2) 4-layer (copper foil density 10.29mm²)
   (2,3-layer copper foil density 5505mm²)
   θ j-a=56.6°C/W
- 3 1-layer (copper foil density 10.29mm<sup>2</sup>)  $\theta$  j-a=178.6°C/W
- 4IC only
  - θ j-a=367.6°C/W

#### Ordering part number



#### VQFN020V4040





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(Note1) Medical Equipment Classification of the Specific Applications

JAPAN	USA	EU	CHINA
CLASSⅢ	CLASSII	CLASS II b	CLASSIII
CLASSIV		CLASSⅢ	

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  - [b] Use of our Products outdoors or in places where the Products are exposed to direct sunlight or dust
  - [c] Use of our Products in places where the Products are exposed to sea wind or corrosive gases, including Cl<sub>2</sub>, H<sub>2</sub>S, NH<sub>3</sub>, SO<sub>2</sub>, and NO<sub>2</sub>
  - [d] Use of our Products in places where the Products are exposed to static electricity or electromagnetic waves
  - [e] Use of our Products in proximity to heat-producing components, plastic cords, or other flammable items
  - [f] Sealing or coating our Products with resin or other coating materials
  - [g] Use of our Products without cleaning residue of flux (even if you use no-clean type fluxes, cleaning residue of flux is recommended); or Washing our Products by using water or water-soluble cleaning agents for cleaning residue after soldering
  - [h] Use of the Products in places subject to dew condensation
- 4. The Products are not subject to radiation-proof design.
- 5. Please verify and confirm characteristics of the final or mounted products in using the Products.
- 6. In particular, if a transient load (a large amount of load applied in a short period of time, such as pulse. is applied, confirmation of performance characteristics after on-board mounting is strongly recommended. Avoid applying power exceeding normal rated power; exceeding the power rating under steady-state loading condition may negatively affect product performance and reliability.
- 7. De-rate Power Dissipation (Pd) depending on Ambient temperature (Ta). When used in sealed area, confirm the actual ambient temperature.
- 8. Confirm that operation temperature is within the specified range described in the product specification.
- 9. ROHM shall not be in any way responsible or liable for failure induced under deviant condition from what is defined in this document.

#### Precaution for Mounting / Circuit board design

- 1. When a highly active halogenous (chlorine, bromine, etc.) flux is used, the residue of flux may negatively affect product performance and reliability.
- 2. In principle, the reflow soldering method must be used; if flow soldering method is preferred, please consult with the ROHM representative in advance.

For details, please refer to ROHM Mounting specification

#### **Precautions Regarding Application Examples and External Circuits**

- If change is made to the constant of an external circuit, please allow a sufficient margin considering variations of the characteristics of the Products and external components, including transient characteristics, as well as static characteristics.
- You agree that application notes, reference designs, and associated data and information contained in this document are presented only as guidance for Products use. Therefore, in case you use such information, you are solely responsible for it and you must exercise your own independent verification and judgment in the use of such information contained in this document. ROHM shall not be in any way responsible or liable for any damages, expenses or losses incurred by you or third parties arising from the use of such information.

#### **Precaution for Electrostatic**

This Product is electrostatic sensitive product, which may be damaged due to electrostatic discharge. Please take proper caution in your manufacturing process and storage so that voltage exceeding the Products maximum rating will not be applied to Products. Please take special care under dry condition (e.g. Grounding of human body / equipment / solder iron, isolation from charged objects, setting of lonizer, friction prevention and temperature / humidity control).

#### **Precaution for Storage / Transportation**

- 1. Product performance and soldered connections may deteriorate if the Products are stored in the places where:
  - [a] the Products are exposed to sea winds or corrosive gases, including Cl2, H2S, NH3, SO2, and NO2
  - [b] the temperature or humidity exceeds those recommended by ROHM
  - the Products are exposed to direct sunshine or condensation
  - [d] the Products are exposed to high Electrostatic
- 2. Even under ROHM recommended storage condition, solderability of products out of recommended storage time period may be degraded. It is strongly recommended to confirm solderability before using Products of which storage time is exceeding the recommended storage time period.
- 3. Store / transport cartons in the correct direction, which is indicated on a carton with a symbol. Otherwise bent leads may occur due to excessive stress applied when dropping of a carton.
- Use Products within the specified time after opening a humidity barrier bag. Baking is required before using Products of which storage time is exceeding the recommended storage time period.

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#### **Precaution for Disposition**

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